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4-Ethoxyanilinium perchlorate

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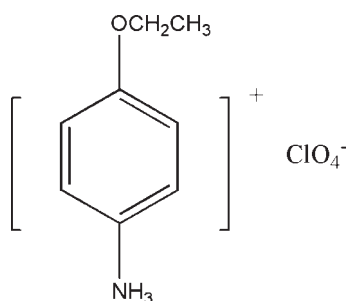
Received 30 July 2009; accepted 31 August 2009

 Key indicators: single-crystal X-ray study; $T = 298$ K; mean $\sigma(\text{C}-\text{C}) = 0.004$ Å; R factor = 0.054; wR factor = 0.138; data-to-parameter ratio = 17.8.

In the title compound, $\text{C}_8\text{H}_{12}\text{NO}^+\cdot\text{ClO}_4^-$, there are strong hydrogen bonds between the ammonium groups and the perchlorate O atoms.

Related literature

This study is a part of systematic investigation of dielectric-ferroelectric materials, including organic ligands (Li *et al.*, 2008), metal-organic coordination compounds (Hang *et al.*, 2009) and organic-inorganic hybrids.



Experimental

Crystal data

 $\text{C}_8\text{H}_{12}\text{NO}^+\cdot\text{ClO}_4^-$
 $M_r = 237.64$

 Monoclinic, $P2_1/c$
 $a = 5.0663$ (10) Å

 $b = 22.601$ (5) Å
 $c = 9.2091$ (18) Å
 $\beta = 91.49$ (3)°
 $V = 1054.1$ (4) Å³
 $Z = 4$

 Mo $K\alpha$ radiation
 $\mu = 0.36$ mm⁻¹
 $T = 298$ K
 $0.20 \times 0.20 \times 0.20$ mm

Data collection

 Rigaku SCXmini diffractometer
 Absorption correction: multi-scan
 (*CrystalClear*; Rigaku, 2005)
 $T_{\min} = 0.928$, $T_{\max} = 0.93$

 9440 measured reflections
 2415 independent reflections
 1795 reflections with $I > 2\sigma(I)$
 $R_{\text{int}} = 0.055$

Refinement

 $R[F^2 > 2\sigma(F^2)] = 0.054$
 $wR(F^2) = 0.138$
 $S = 1.04$
 2415 reflections

 136 parameters
 H-atom parameters constrained
 $\Delta\rho_{\max} = 0.25$ e Å⁻³
 $\Delta\rho_{\min} = -0.47$ e Å⁻³

Table 1

Hydrogen-bond geometry (Å, °).

$D-H\cdots A$	$D-H$	$H\cdots A$	$D\cdots A$	$D-H\cdots A$
$\text{N1}-\text{H1A}\cdots\text{O4}^{\text{i}}$	0.89	2.14	3.019 (3)	167
$\text{N1}-\text{H1B}\cdots\text{O4}^{\text{ii}}$	0.89	2.13	2.981 (3)	161
$\text{N1}-\text{H1B}\cdots\text{Cl1}^{\text{ii}}$	0.89	2.87	3.567 (2)	136
$\text{N1}-\text{H1F}\cdots\text{O3}^{\text{iii}}$	0.89	2.29	2.889 (3)	124
$\text{N1}-\text{H1F}\cdots\text{O5}$	0.89	2.29	3.046 (3)	143

 Symmetry codes: (i) $x + 1, -y + \frac{1}{2}, z - \frac{1}{2}$; (ii) $x, -y + \frac{1}{2}, z - \frac{1}{2}$; (iii) $x + 1, y, z$.

Data collection: *CrystalClear* (Rigaku, 2005); cell refinement: *CrystalClear*; data reduction: *CrystalClear*; program(s) used to solve structure: *SHELXS97* (Sheldrick, 2008); program(s) used to refine structure: *SHELXL97* (Sheldrick, 2008); molecular graphics: *SHELXTL* (Sheldrick, 2008); software used to prepare material for publication: *PRPKAPPA* (Ferguson, 1999).

The authors are grateful to the starter fund of Southeast University for financial support to buy the X-ray diffractometer.

Supplementary data and figures for this paper are available from the IUCr electronic archives (Reference: JH2099).

References

- Ferguson, G. (1999). *PRPKAPPA*. University of Guelph, Canada.
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 Rigaku (2005). *CrystalClear*. Rigaku Corporation, Tokyo, Japan.
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supplementary materials

Acta Cryst. (2009). E65, o2345 [doi:10.1107/S1600536809035041]

4-Ethoxyanilinium perchlorate

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Comment

This study is a part of systematic investigation of dielectric-ferroelectric materials, including organic ligands (Li *et al.*, 2008), metal-organic coordination compounds (Hang *et al.*, 2009) and organic-inorganic hybrid. 4-Ethoxyanilinium perchlorate has no dielectric disuniform from 80 K to 450 K, (m.p. 459–460 K).

The asymmetric unit of the title compound is composed of cationic ($\text{C}_2\text{H}_5\text{O}-\text{C}_6\text{H}_4-\text{NH}_3^+$) and anionic (ClO_4^-)(Fig 1). The average Cl—O bond distances and O—Cl—O bond angles are 1.427 (2)Å and 109.46 (14)°, respectively, confirming a tetrahedral configuration. The strong N—H \cdots O hydrogen bonding (Table 1) (N1—H \cdots O3 2.889 (3) Å) make great contribution to the stability of the crystal structure and link the cations and anions to chains along the *a* axis (Fig 2).

Experimental

Single crystals of 4-ethoxyaniliniumperchlorate are prepared by slow evaporation at room temperature of an ethanol solution of 4-ethoxybenzenamine and perchloric acid.

Refinement

Positional parameters of all the H atoms were calculated geometrically and were allowed to ride on the C atoms to which they are bonded, with $U_{\text{iso}}(\text{H}) = 1.2U_{\text{eq}}(\text{C})$.

Figures

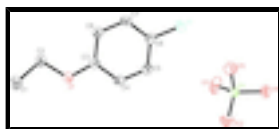


Fig. 1. The molecular structure of the title compound, with the atomic numbering scheme. Displacement ellipsoids are drawn at the 30% probability level, and all H atoms have been omitted for clarity.

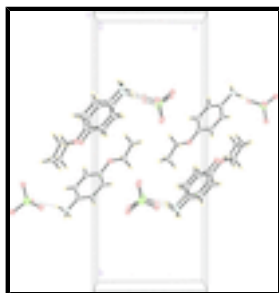


Fig. 2. A view of the packing of the title compound, stacking along the *a* axis. Dashed lines indicate hydrogen bonds.

4-Ethoxyanilinium perchlorate

Crystal data

$C_8H_{12}NO^+ \cdot ClO_4^-$

$M_r = 237.64$

Monoclinic, $P2_1/c$

Hall symbol: -P 2ybc

$a = 5.0663$ (10) Å

$b = 22.601$ (5) Å

$c = 9.2091$ (18) Å

$\beta = 91.49$ (3)°

$V = 1054.1$ (4) Å³

$Z = 4$

$F_{000} = 496$

$D_x = 1.497$ Mg m⁻³

Mo $K\alpha$ radiation, $\lambda = 0.71073$ Å

Cell parameters from 4042 reflections

$\theta = 3.5$ – 27.6 °

$\mu = 0.36$ mm⁻¹

$T = 298$ K

Prism, colourless

$0.20 \times 0.20 \times 0.20$ mm

Data collection

Rigaku SCXmini
diffractometer

Radiation source: fine-focus sealed tube

Monochromator: graphite

Detector resolution: 13.6612 pixels mm⁻¹

$T = 298$ K

ω scans

Absorption correction: multi-scan
(CrystalClear; Rigaku, 2005)

$T_{\min} = 0.928$, $T_{\max} = 0.93$

9440 measured reflections

2415 independent reflections

1795 reflections with $I > 2\sigma(I)$

$R_{\text{int}} = 0.055$

$\theta_{\max} = 27.5$ °

$\theta_{\min} = 3.5$ °

$h = -6 \rightarrow 6$

$k = -29 \rightarrow 29$

$l = -11 \rightarrow 10$

Refinement

Refinement on F^2

Least-squares matrix: full

$R[F^2 > 2\sigma(F^2)] = 0.054$

$wR(F^2) = 0.138$

$S = 1.04$

2415 reflections

136 parameters

Primary atom site location: structure-invariant direct
methods

Secondary atom site location: difference Fourier map

Hydrogen site location: inferred from neighbouring
sites

H-atom parameters constrained

$w = 1/[\sigma^2(F_o^2) + (0.0663P)^2 + 0.3412P]$

where $P = (F_o^2 + 2F_c^2)/3$

$(\Delta/\sigma)_{\max} < 0.001$

$\Delta\rho_{\max} = 0.25$ e Å⁻³

$\Delta\rho_{\min} = -0.47$ e Å⁻³

Extinction correction: none

Special details

Geometry. All e.s.d.'s (except the e.s.d. in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell e.s.d.'s are taken into account individually in the estimation of e.s.d.'s in distances, angles and torsion angles; correlations between e.s.d.'s in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell e.s.d.'s is used for estimating e.s.d.'s involving l.s. planes.

Refinement. Refinement of F^2 against ALL reflections. The weighted R -factor wR and goodness of fit S are based on F^2 , conventional R -factors R are based on F , with F set to zero for negative F^2 . The threshold expression of $F^2 > \sigma(F^2)$ is used only for calculating R -factors(gt) *etc.* and is not relevant to the choice of reflections for refinement. R -factors based on F^2 are statistically about twice as large as those based on F , and R -factors based on ALL data will be even larger.

Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters (\AA^2)

	<i>x</i>	<i>y</i>	<i>z</i>	$U_{\text{iso}}^*/U_{\text{eq}}$
Cl1	-0.00925 (11)	0.32367 (2)	0.57673 (6)	0.0340 (2)
N1	0.4143 (4)	0.28041 (9)	0.2574 (2)	0.0385 (5)
H1A	0.5458	0.2568	0.2319	0.058*
H1B	0.2657	0.2595	0.2616	0.058*
H1F	0.4517	0.2961	0.3441	0.058*
O5	0.2716 (4)	0.31960 (9)	0.5619 (2)	0.0524 (5)
C7	0.5402 (5)	0.33118 (11)	0.0325 (3)	0.0407 (6)
H7A	0.6706	0.3028	0.0205	0.049*
O1	0.2682 (4)	0.46533 (8)	-0.1381 (2)	0.0491 (5)
C6	0.3806 (5)	0.32820 (10)	0.1488 (3)	0.0343 (5)
C3	0.3145 (5)	0.41839 (11)	-0.0489 (3)	0.0379 (6)
O4	-0.0842 (4)	0.28604 (9)	0.6953 (2)	0.0508 (5)
C8	0.5097 (5)	0.37615 (11)	-0.0678 (3)	0.0412 (6)
H8A	0.6187	0.3782	-0.1473	0.049*
O3	-0.1320 (4)	0.30237 (11)	0.4463 (2)	0.0690 (7)
C4	0.1528 (5)	0.41445 (12)	0.0693 (3)	0.0481 (7)
H4B	0.0210	0.4425	0.0814	0.058*
C5	0.1838 (5)	0.36977 (13)	0.1689 (3)	0.0477 (7)
H5B	0.0749	0.3674	0.2485	0.057*
C2	0.4325 (7)	0.47354 (13)	-0.2604 (3)	0.0537 (8)
H2A	0.4204	0.4397	-0.3249	0.064*
H2B	0.6153	0.4786	-0.2289	0.064*
O2	-0.0857 (5)	0.38241 (9)	0.6044 (3)	0.0738 (7)
C1	0.3323 (8)	0.52830 (15)	-0.3361 (4)	0.0750 (11)
H1C	0.4367	0.5360	-0.4196	0.112*
H1D	0.3447	0.5613	-0.2707	0.112*
H1E	0.1513	0.5226	-0.3664	0.112*

Atomic displacement parameters (\AA^2)

	U^{11}	U^{22}	U^{33}	U^{12}	U^{13}	U^{23}
Cl1	0.0336 (4)	0.0366 (3)	0.0317 (4)	-0.0012 (2)	0.0009 (2)	0.0012 (2)

supplementary materials

N1	0.0387 (13)	0.0395 (12)	0.0367 (12)	-0.0015 (9)	-0.0069 (9)	0.0010 (9)
O5	0.0312 (11)	0.0653 (13)	0.0610 (14)	-0.0010 (8)	0.0053 (9)	0.0067 (10)
C7	0.0417 (15)	0.0362 (14)	0.0441 (15)	0.0104 (11)	0.0001 (12)	-0.0050 (11)
O1	0.0579 (13)	0.0459 (11)	0.0442 (12)	0.0144 (9)	0.0143 (9)	0.0122 (8)
C6	0.0343 (14)	0.0338 (12)	0.0344 (14)	-0.0023 (10)	-0.0052 (10)	0.0007 (10)
C3	0.0384 (15)	0.0376 (13)	0.0379 (15)	0.0027 (10)	0.0016 (11)	0.0014 (10)
O4	0.0505 (13)	0.0586 (12)	0.0437 (11)	-0.0009 (9)	0.0078 (9)	0.0163 (9)
C8	0.0474 (17)	0.0410 (14)	0.0357 (15)	0.0051 (11)	0.0103 (12)	-0.0004 (11)
O3	0.0636 (16)	0.1054 (19)	0.0375 (12)	-0.0328 (13)	-0.0096 (10)	-0.0041 (11)
C4	0.0420 (17)	0.0505 (16)	0.0523 (18)	0.0139 (12)	0.0129 (13)	0.0090 (13)
C5	0.0413 (17)	0.0547 (17)	0.0477 (17)	0.0079 (12)	0.0135 (13)	0.0097 (13)
C2	0.074 (2)	0.0434 (16)	0.0442 (17)	0.0078 (13)	0.0200 (15)	0.0042 (12)
O2	0.0894 (18)	0.0380 (12)	0.0948 (18)	0.0172 (11)	0.0180 (14)	0.0021 (11)
C1	0.113 (3)	0.059 (2)	0.055 (2)	0.0190 (19)	0.026 (2)	0.0138 (16)

Geometric parameters (Å, °)

C11—O2	1.408 (2)	C6—C5	1.386 (4)
C11—O3	1.422 (2)	C3—C4	1.382 (4)
C11—O5	1.4358 (19)	C3—C8	1.389 (3)
C11—O4	1.4426 (19)	C8—H8A	0.9300
N1—C6	1.479 (3)	C4—C5	1.371 (4)
N1—H1A	0.8900	C4—H4B	0.9300
N1—H1B	0.8900	C5—H5B	0.9300
N1—H1F	0.8900	C2—C1	1.502 (4)
C7—C6	1.361 (4)	C2—H2A	0.9700
C7—C8	1.379 (4)	C2—H2B	0.9700
C7—H7A	0.9300	C1—H1C	0.9600
O1—C3	1.358 (3)	C1—H1D	0.9600
O1—C2	1.430 (3)	C1—H1E	0.9600
O2—C11—O3	110.83 (16)	C7—C8—C3	119.4 (2)
O2—C11—O5	110.84 (14)	C7—C8—H8A	120.3
O3—C11—O5	108.09 (13)	C3—C8—H8A	120.3
O2—C11—O4	109.88 (14)	C5—C4—C3	121.0 (2)
O3—C11—O4	108.77 (13)	C5—C4—H4B	119.5
O5—C11—O4	108.36 (12)	C3—C4—H4B	119.5
C6—N1—H1A	109.5	C4—C5—C6	118.7 (3)
C6—N1—H1B	109.5	C4—C5—H5B	120.7
H1A—N1—H1B	109.5	C6—C5—H5B	120.7
C6—N1—H1F	109.5	O1—C2—C1	106.0 (2)
H1A—N1—H1F	109.5	O1—C2—H2A	110.5
H1B—N1—H1F	109.5	C1—C2—H2A	110.5
C6—C7—C8	120.3 (2)	O1—C2—H2B	110.5
C6—C7—H7A	119.8	C1—C2—H2B	110.5
C8—C7—H7A	119.8	H2A—C2—H2B	108.7
C3—O1—C2	118.9 (2)	C2—C1—H1C	109.5
C7—C6—C5	121.1 (2)	C2—C1—H1D	109.5
C7—C6—N1	120.5 (2)	H1C—C1—H1D	109.5
C5—C6—N1	118.4 (2)	C2—C1—H1E	109.5

O1—C3—C4	115.5 (2)	H1C—C1—H1E	109.5
O1—C3—C8	125.0 (2)	H1D—C1—H1E	109.5
C4—C3—C8	119.5 (2)		
C8—C7—C6—C5	0.4 (4)	O1—C3—C4—C5	-178.6 (2)
C8—C7—C6—N1	-179.4 (2)	C8—C3—C4—C5	0.6 (4)
C2—O1—C3—C4	178.1 (3)	C3—C4—C5—C6	-0.2 (4)
C2—O1—C3—C8	-1.1 (4)	C7—C6—C5—C4	-0.3 (4)
C6—C7—C8—C3	0.0 (4)	N1—C6—C5—C4	179.5 (2)
O1—C3—C8—C7	178.6 (2)	C3—O1—C2—C1	179.9 (3)
C4—C3—C8—C7	-0.5 (4)		

Hydrogen-bond geometry (Å, °)

<i>D</i> —H \cdots <i>A</i>	<i>D</i> —H	H \cdots <i>A</i>	<i>D</i> \cdots <i>A</i>	<i>D</i> —H \cdots <i>A</i>
N1—H1A \cdots O4 ⁱ	0.89	2.14	3.019 (3)	167
N1—H1B \cdots O4 ⁱⁱ	0.89	2.13	2.981 (3)	161
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Fig. 1

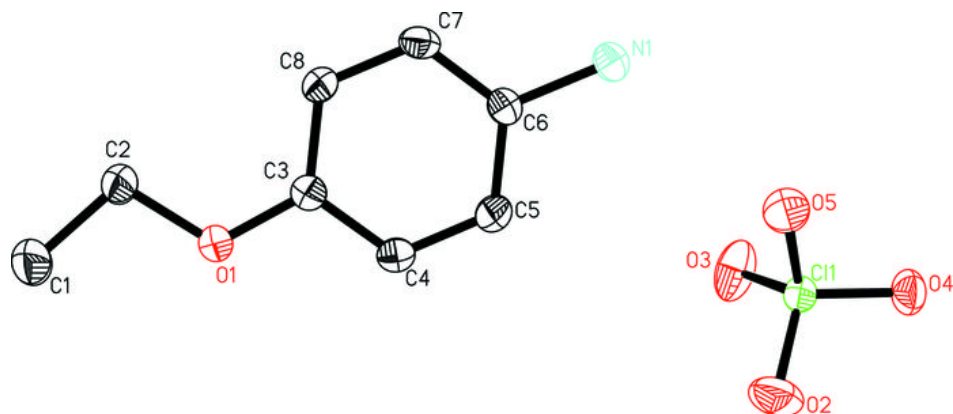


Fig. 2

